

## INFORMATION DISCLOSURE STATEMENT BY APPLICANTS PTO FORM 1449

Atty. Docket No. 10191/1639	Serial No. To Be Assigned
Applicant(s) GLOECKLER et al.	15867 15867
Filing Date Herewith	Group To Be Assigned To Be

## U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NUMBER	PATENT DATE	NAME	CLASS	SUBCLASS	FILING DATE

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION	
Milital	NOMBER	DATE		C2.100		YES	NO

## OTHER DOCUMENTS

EXAMINER'S INITIALS		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.		
		SUN MICROELECTRONICS, Mountain View, CA, USA, "Introduction to JTAG Boundary-Scan", White Paper, January 1997, Part No. WPR-0018-01, and on the Internet on the web page "Analoges Boundary Scan, IEEE P1149.4"*		
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* Described in the S	pecification.	W.		
EXAMINER	H		DATE CONSIDERED 6 / 30/200 3	
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